



Title of Change:	Qualification of additional probe test site to Cebu, Philippines, from Bucheon, Korea.										
Proposed first ship date:	10 October 2019										
Contact information:	Contact your local ON Semiconductor Sales Office or <sangseop.kim@onsemi.com>										
Samples:	Contact your local ON Semiconductor Sales Office or <PCN.samples@onsemi.com> Sample requests are to be submitted no later than 30 days from the date of first notification, Initial PCN or Final PCN, for this change. Samples delivery timing will be subject to request date, sample quantity and special customer packing/label requirements.										
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or <Aileen.Allado@onsemi.com>.										
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <PCN.Support@onsemi.com>										
Change Part Identification:	Material marked with date code 1944 or later will be assembled with wafers which are probed at ON Cebu or earlier if agreed to by customer.										
Change Category:	<input type="checkbox"/> Wafer Fab Change <input type="checkbox"/> Assembly Change <input checked="" type="checkbox"/> Test Change <input type="checkbox"/> Other _____										
Change Sub-Category(s):	<input checked="" type="checkbox"/> Manufacturing Site Addition <input type="checkbox"/> Material Change <input type="checkbox"/> Datasheet/Product Doc change <input type="checkbox"/> Manufacturing Site Transfer <input type="checkbox"/> Product specific change <input type="checkbox"/> Shipping/Packaging/Marking <input type="checkbox"/> Manufacturing Process Change <input type="checkbox"/> Other: _____										
Sites Affected:	ON Semiconductor Sites: ON Cebu, Philippines and ON Bucheon, Korea	External Foundry/Subcon Sites: None									
Description and Purpose:	ON Semiconductor would like to notify our customers of our qualification the product listed in this FPCN at our ON Cebu, Philippines. <table border="1" style="margin: 10px auto; border-collapse: collapse;"> <thead> <tr style="background-color: #92d050;"> <th></th> <th>Before Change Description</th> <th>After Change Description</th> </tr> </thead> <tbody> <tr> <td style="text-align: center;">Prober Site</td> <td style="text-align: center;">ON Bucheon Korea</td> <td style="text-align: center;">ON Bucheon, Korea</td> </tr> <tr> <td></td> <td></td> <td style="text-align: center;">ON Cebu, Philippines</td> </tr> </tbody> </table>			Before Change Description	After Change Description	Prober Site	ON Bucheon Korea	ON Bucheon, Korea			ON Cebu, Philippines
	Before Change Description	After Change Description									
Prober Site	ON Bucheon Korea	ON Bucheon, Korea									
		ON Cebu, Philippines									
Reliability Data Summary:	Reliability is not impacted.										
Electrical Characteristic Summary:	Electrical characteristics are not impacted by this change. Electrical comparison reports are available upon request.										

**List of Affected Parts:**

Note: Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the **PCN Customized Portal**.

FAN3181TMX
FL7760AM6X
FL7760BM6X
FSL3276ALRN
FSL336LRLX
FSL336LRN
FSL337LRN
NCP51705MNTXG

Appendix A: Changed Products

Product	Customer Part Number	Qualification Vehicle
FAN3181TMX		NA
FL7760AM6X		NA
FL7760BM6X		NA
FSL3276ALRN		NA
FSL336LRDN		NA
FSL336LRLX		NA
FSL336LRN		NA
FSL337LRN		NA
NCP51705MNTXG		NA